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# HYDROGEN GAS SENSING PERFORMANCE OF A Pt/GRAPHENE/SiC DEVICE

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### ABSTRACT

In this work, we present the development of a Pt/graphene/SiC device for hydrogen gas sensing. A single layer of graphene was deposited on 6H-SiC via chemical vapor deposition. The presence of graphene C-C observed via X-ray photoelectron bonds was spectroscopy analysis. Current-voltage characteristics of the device were measured at the presence of hydrogen at different temperatures, from 25°C to 170°C. The dynamic response of the device was recorded towards hydrogen gas at an optimum temperature of 130°C. A voltage shift of 191 mV was recorded towards 1% hydrogen at -1 mA constant current.

## **KEYWORDS**

Graphene, Hydrogen, Sensor, Chemical Vapor Deposition.

## **1. INTRODUCTION**

In recent years, much research effort has been devoted to investigation of graphene as a gas sensing material due to its unique properties. These include room temperature ballistic electronic transport [1, 2], strong hydrogen affinity [3], metal-like characteristics [4-6] and its large surface area, which make graphene incredibly well suited for gas sensing applications [7-13].

Graphene is a two-dimensional material comprising carbon atoms arranged in six-membered rings [2, 4, 14, 15]. It can be classified as: a single-layer graphene (SG), bilayer graphene (BG) and few-layer graphene (FG, number of layers  $\leq 10$ ) [15]. Many techniques have been developed for the deposition of graphene. A micro-mechanical cleavage method was initially used to exfoliate highly oriented pyrolitic graphite using 'scotch-tape' [2]. Other methods include a direct epitaxial growth of graphene from SiC via thermal decomposition [16], chemical vapor deposition (CVD) [17] and the synthesis of graphene via a chemical reduction of graphite oxide [18].

In this work, a Pt/graphene/SiC device for hydrogen gas applications has been developed. SiC is a favourable substrate for the formation of graphene-based sensors due to the fact that graphene can be epitaxially grown on SiC by annealing at elevated temperatures [19]. Pt was chosen as the electrode metal as it forms an electrical contact and also it functions as an excellent hydrogen catalyst. The work herein investigates a graphene based device as it is applied as a sensor toward hydrogen with different concentrations in a synthetic air. The current-voltage (I-V) characteristics are studied as a function of temperature and hydrogen concentration. The electron transport mechanism at the Pt/graphene and graphene/SiC interfaces are also investigated and used to explain the sensing performance.

## 2. EXPERIMENTAL

A Pt/graphene based device was fabricated on *n*-type 6H-SiC substrate (Tankeblue Co. Ltd.). The native oxide on the substrate surface was removed via etching in hydrofluoric acid. A double metal layer of Ti/Pt (40/100 nm) was deposited at the unpolished backside of the substrate using electron beam evaporation. Subsequently, the samples were annealed at 500°C in N<sub>2</sub> for 30 min to form an electrical contact.

A single layer of graphene was grown on Cu foils by CVD technique using methane as a precursor. The as-grown graphene layer was spin-coated with a thin layer of polymethyl metha-acrylate (PMMA). This film was separated from the Cu foil by dissolving in diluted ferric chloride solution. The graphene/PMMA was then transferred onto a SiC substrate. Subsequently, the PMMA film was removed by heating at 500°C with a stream of hydrogen gas.

Finally, a circular pad of Pt (~25 nm thickness) was deposited onto the graphene layer to form the electrical contact. The fabricated Pt/graphene/SiC device was placed in a multichannel gas testing system to investigate their electrical properties and gas sensing performance. The testing process has been explained in our previous works [8, 9, 20, 21].

#### **3. RESULTS AND DISCUSSION**

The deposited graphene layers were characterized by transmission electron microscopy (TEM), X-ray photoelectron spectroscopy (XPS) and Raman spectroscopy. Figure 1 shows the TEM micrographs of the graphene layer. The thickness of the synthesized graphene material was measured to be ~0.3 nm.

XPS analysis (Figure 2) revealed a peak at 285.0 eV which identifies the C-C bond and is ascribed to graphene [22]. An attenuated Si-C peak was observed at 283.3eV [23]. Other bonds that were identified include C-OH (285.9eV), C=O (287.1eV) and C-C=O (289.2eV) [22].



Figure 1: TEM micrograph of the graphene layer.



Figure 2: XPS spectra of graphene layer deposited on a SiC substrate.

Raman spectroscopy was used to characterize the quality and thickness of the graphene. The major features of the Raman spectrum are the G band at 1584 cm<sup>-1</sup> and the 2D band at 2690 cm<sup>-1</sup>. The G band is due to the  $E_{2g}$  vibrational mode, and the 2D band is a second order two phonon mode. The D band at 1350 cm<sup>-1</sup> is not Raman active for pristine graphene but can be observed where symmetry is broken by edges or in samples with some defects. The shape, position and intensity of 2D band depend on the number of layers. The strong and symmetrical Lorentzian 2D band and the weak intensity of the D band indicate the CVD-grown graphene was of reasonably good quality.



Figure 3: Raman spectrum of the CVD-grown graphene layer.



Figure 4: Plot of voltage shift of Pt/graphene/SiC device as a function of temperature towards different hydrogen gas concentrations at a constant reverse bias current of 1 mA.

The *I-V* characteristics and dynamic responses of the Pt/graphene/SiC device were measured at the presence of hydrogen gas at temperatures of 25, 35, 60, 100, 130 and 170°C. The most significant hydrogen response was found at 130°C and was chosen as the optimal operating temperature. Figure 4 shows the measured voltage shifts of the device as a function of temperature at different hydrogen concentrations.

Figure 5 shows the *I-V* characteristics of the Pt/graphene/SiC device at the presence of hydrogen (with different concentrations of 0.06, 0.125, 0.25, 0.5, 1%) at 130°C. The device was therefore operated in reverse bias as the voltage shift towards hydrogen was significantly larger than in forward bias.

The *I-V* characteristics of the Pt/graphene/SiC device can be explained by the electron transport mechanism at two interfaces of Pt/graphene and graphene/SiC [8]. Initially, the electron transfer will encounter a transition from the *n*-type SiC to the semi-metallic graphene and then to the metallic Pt. The conduction behaviour will be similar to that between a metal to a metal junction. However, the non-linear *I-V* curves (Figure 5) were observed as the graphene behaves semi-metal like.



Figure 5: I-V characteristics of the Pt/graphene/SiC device at the presence of hydrogen gas at 130°C.

Giovannetti et al. [24] showed that as a thin Pt layer is deposited on the graphene layer, it physisorbs onto the surface and leads to a weak interaction energy (van der Waals) at the Pt/graphene interface and hence preserves the electronic structure of graphene. As the work function of Pt ( $W_M$ ) is larger than work function of graphene ( $W_G$ ), it causes electrons transfer from graphene to Pt and as a result the Fermi levels achieve equilibrium. This electron transfer between the Pt and graphene results in the formation of a dipole layer at the interface and forms a potential step ( $\Delta V$ ) as shown in the energy-band diagram (Figure 6) of Pt on graphene [24].

It is assumed that the graphene layer acts as 'semi-metal' like when deposited on SiC substrate as shown by Tongay et al. [25]; and the main transport mechanism at the graphene/SiC interface is dominated by thermionic emission.

Upon exposure of the device to hydrogen gas, the dissociation of hydrogen molecules occurs on the Pt surface. Then hydrogen atoms diffuse through the Pt catalyst onto graphene. Here, two assumptions are made [8]: (1) the work function of graphene ( $W_G$ ) increases; and/or (2) the separation distance between the Pt and graphene (d) increases, which causes an increase in the Fermi-level shift ( $\Delta E_F$ ) [24]. Both increases in  $\Delta E_F$  and  $W_G$  decrease the potential step according to Equation (1):

$$\Delta V = W_{Pt} - W_G - \Delta E_F \tag{1}$$

Therefore, this decrease results in an increase in the current density in the *I-V* characteristics.

The dynamic response of the device was measured at  $130^{\circ}$ C, towards different hydrogen concentrations at a constant reverse bias current of 1 mA (Figure 7). Voltage shifts of 6, 18, 41, 91 and 191 mV were recorded for 0.06, 0.125, 0.25, 0.5 and 1% hydrogen, respectively. The device showed a stable baseline and excellent repeatability over a period of two weeks testing towards hydrogen.



Figure 6: A theoretical energy-band diagram of a Pt/graphene contact, where  $W_M$  is the Pt work function;  $W_G$  is the graphene work function; W is the Pt-coated graphene work function; d is the equilibrium separation distance;  $\Delta E_F$  is the Fermi-level shift, and  $\Delta V$  is the potential change generated by the Pt/graphene interaction.



Figure 7: Dynamic response of the Pt/graphene/SiC device towards 0.06, 0.125, 0.25, 0.5 and 1% hydrogen gas in synthetic air at  $130^{\circ}$ C.

## **4. CONCLUSION**

A hydrogen gas sensor based on Pt/graphene/SiC device was successfully fabricated. The TEM showed a single layer of graphene with thickness of ~0.3 nm. The developed device operated at an optimal temperature of 130°C. A voltage shift of 191 mV was recorded for 1% hydrogen at 130°C at a reverse constant bias of -1 mA. These results also indicated that hydrogen gas is readily adsorbed and desorbed from the device, which attribute to its repeatability over two weeks of testing.

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